

HAC TEST REPORT

Test Item: Summary Result HAC Category = M3

REPORT NO.: HA970604L10

MODEL NO.: RAPH800

RECEIVED: Jun. 04, 2008

TESTED: Jun. 13, 2008

ISSUED: Jun. 17, 2008

APPLICANT: High Tech Computer Corp.

ADDRESS: 23, Hsin-Hua Rd., Taoyuan, 330, Taiwan, R.O.C.

ISSUED BY: Advance Data Technology Corporation

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1. CERTIFICATION

PRODUCT: Pocket PC Phone

MODEL NO.: RAPH800

APPLICANT: High Tech Computer Corp.

TESTED: Jun. 13, 2008

TEST SAMPLE: Engineering sample

STANDARDS: FCC Part 20.19

ANSI PC63.19 2006

TEST ITEM: RF emissions

The above equipment (model no: RAPH800) have been tested by **Advance Data Technology Corporation**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's characteristics under the conditions specified in this report.

PREPARED BY: Wendy Liw , DATE: Jun. 17, 2008

Wendy Liab / Senior Specialist

ACCEPTANCE: James Jam , DATE: Jun. 17, 2008

Responsible for RF James Fan / Engineer

APPROVED BY: Jan. 17, 2008



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

PRODUCT	Pocket PC Phone
MODEL NO.	RAPH800
FCC ID	NM8RAPH800
POWER SUPPLY	3.7Vdc from rechargeable lithium battery 5.0Vdc from power adapter
	5.0Vdc from host equipment
CLASSIFICATION	Portable device, production unit
MODULATION TYPE	OQPSK, HPSK
FREQUENCY RANGE	Tx: 824.2 ~ 848.8MHz / Rx: 869.2 ~ 893.8MHz (CDMA850) Tx: 1850.2 ~ 1909.8MHz / Rx: 1930.2 ~ 1989.8MHz (CDMA1900)
CHANNEL FREQUENCIES UNDER TEST AND ITS CONDUCTED OUTPUT POWER	CDMA850: 24.06dBm / 824.70MHz for channel 1013 24.28dBm / 836.50MHz for channel 384 24.41dBm / 848.30MHz for channel 777 CDMA1900: 24.12dBm / 1851.25MHz for channel 25 24.23dBm / 1880.00MHz for channel 600 24.45dBm / 1908.75MHz for channel 1175
HAC RATE CATEGORY	M3
ANTENNA TYPE	PIFA antenna with 0dBi gain for CDMA850 PIFA antenna with 1dBi gain for CDMA1900
DATA CABLE	1.25m shielded USB cable without core 0.1m shielded USB 4-in-1 cable without core
I/O PORTS	Refer to user's manual
ACCESSORY DEVICES	Adapter, Battery, Earphone (Brand: hTC, model: HS S300, 1.9m), Pouch

- 1. The EUT is a CDMA850/CDMA1900 (1XEVDO) Pocket PC Phone with wireless LAN and bluetooth functions.
- 2. The communicated functions of EUT listed as below:

		850MHz	1900MHz	
	CDMA	V	V	
3G	1*EVDO	V		With WLAN 802.11b/g + BT 2.0 with EDR + AGPS
36	1*RTT	V	V	
	IS-95A/B	V	V	



3. The EUT has Li-ion battery listed as below:

	,
BRAND:	hTC
MODEL:	DIAM171
RATING:	3.7Vdc, 1340mAh

4. The EUT was operated with following power adapter:

BRAND:	hTC
MODEL:	TC P300
INPUT:	100-240Vac, 0.2A, 50-60Hz
OUTPUT:	5Vdc, 1A

5. The MEID code listed as below:

A10	00007**	****
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- 6. The EUT used the same antenna for Wireless LAN & Bluetooth function, but the two functions can not work at the same time.
- 7. The above EUT information was declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or User's Manual.



2.2 DESCRIPTIONOF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

NO.	PRODUCT	BRAND	MODEL NO.	SERIAL NO.	CALIBRATED UNTIL
1	Universal Radio Communication Tester	R&S	CMU200	101372	Nov. 25, 2008

NO.	SIGNAL CABLE DESCRIPTION OF THE ABOVE SUPPORT UNITS
1	NA

NOTE: All power cords of the above support units are non shielded (1.8m).

2.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

According to the specifications of the manufacturer, this product must comply with the requirements of the following standards:

FCC Part 20.19

ANSI PC63.19 - 2006

All test items have been performed and recorded as per the above standards.



3. GENERAL INFORMATION OF THE DASY4 SYSTEM

3.1. GENERAL INFORMATION OF TEST EQUIPMENT

DASY4 (software 4.7 Build 53) consists of high precision robot, probe alignment sensor, phantom, robot controller, controlled measurement server and near-field probe. The robot includes six axes that can move to the precision position of the DASY4 software defined. The DASY4 software can define the area that is detected by the probe. The robot is connected to controlled box. Controlled measurement server is connected to the controlled robot box. The DAE includes amplifier, signal multiplexing, AD converter, offset measurement and surface detection. It is connected to the Electro-optical coupler (ECO). The ECO performs the conversion form the optical into digital electric signal of the DAE and transfers data to the PC.

ER3DV6 E-FIELD PROBE

CONSTRUCTION One dipole parallel, two dipoles normal to probe axis Built-in shielding against

static charges

CALIBRATION In air from 100MHz to 3.0GHz (absolute accuracy \pm 6.0%, k = 2)

FREQUENCY 100MHz to > 6GHz; Linearity: ± 0.2dB (100MHz to 3GHz)

DIRECTIVITY \pm 0.2dB in air (rotation around probe axis)

± 0.4dB in air (rotation normal to probe axis)

DYNAMIC RANGE 2V/m to > 1000V/m (M3 or better device readings fall well below diode

compression point) Linearity: ± 0.2dB

DIMENSIONS Overall length: 330mm (Tip: 16mm)

Tip diameter: 8mm (Body: 12mm)

Distance from probe tip to dipole centers: 2.5mm



H3DV6 H-FIELD PROBE

CONSTRUCTION Three concentric loop sensors with 3.8mm loop diameters Resistively loaded

detector diodes for linear response Built-in shielding against static charges

FREQUENCY 200MHz to 3GHz (absolute accuracy \pm 6.0%, k = 2); Output linearized

DIRECTIVITY ± 0.25dB (spherical isotropy error)

DYNAMIC RANGE 10mA/m to 2A/m at 1GHz (M3 or better device readings fall well below diode

compression point)

DIMENSIONS Overall length: 330mm (Tip: 40mm)

Tip diameter: 6mm (Body: 12mm)

Distance from probe tip to dipole centers: 3mm

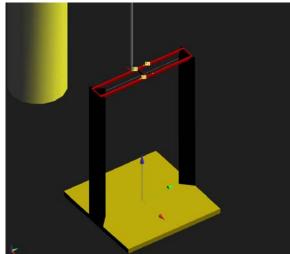
E-FIELD < 10% at 3GHz (for plane wave)

INTERFERENCE

NOTE: The Probe parameters have been calibrated by the SPEAG. Please reference "APPENDIX D" for the Calibration Certification Report.

HAC ARCH





DIMENSIONS 370 x 370 x 370mm



SYSTEM VALIDATION KITS:

Frequency Band: 800 ~ 960MHz (free space)

Return Loss: > 15dB

CD835V3 Calibrated at: 835MHz

Power Capability: 50W continuous Length & Height: 166 x 330mm

Frequency Band: 1710 ~ 2000MHz (free space)

Return Loss: > 18dB

CD1880V3 Calibrated at: 1880MHz

Power Capability: 50W continuous **Length & Height:** 80.8 x 330mm

Frequency Band: 2250 ~ 2650MHz (free space)

Return Loss: > 18dB

CD2450V3 Calibrated at: 2450MHz

Power Capability: 50W continuous Length & Height: 60 x 330mm



DEVICE HOLDER





CONSTRUCTION Supports accurate and reliable positioning of any phone effect on near field <+/- 0.5dB



DATA ACQUISITION ELECTRONICS (DAE)



CONSTRUCTION

The data acquisition electronics (DAE3) consists of a highly sensitive electrometer grade preamplifier with auto-zeroing, a channel and gain-switching multiplex, a fast 16 bit AD converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock. The mechanical probe is mounting device includes two different sensor systems for frontal and sideways probe contacts. They are used for mechanical surface detection and probe collision detection. The input impedance of the DAE3 box is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.



3.2. TEST EQUIPMENT LIST

ITEM	NAME	BAND	TYPE	SERIES NO.	CALIBRATED UNTIL
1	SAM Phantom	S&P	SD HAC P01 BA	1034	NA
2	Robot Positioner	Staubli Unimation	NIΔ		NA
3	Signal Generator	Agilent	E8257C	MY43320668	Dec. 25, 2008
4	E-Field Probe	Speag	ER3DV6	2293	Jan. 22, 2009
5	H-Field Probe	Speag	H3DV6	6124	Jan. 22, 2009
6	DAE	Speag	DAE3 V1	510	Aug. 28, 2008
7	Validation Dipole	Speag	CD835V3	1041	May 13, 2010
/	vandation Dipole	Opeag	CD1880V3	1032	Jul. 17, 2008

NOTE: Before starting the measurement, all test equipment shall be warmed up for 30min.



3.3. MEASUREMENT UNCERTAINTY

HAC UNCERTAINTY BUDGET ACCORDING TO ANSI C63.19[1]									
ERROR DESCRIPTION	UNCERTAINTY VALUE	PROBABILITY DISTRIBUTION	DIVISOR	(Ci)E	(Ci) H	STD. UNC. E	STD. UNC. H		
	MEASUREMENT SYSTEM								
Probe calibration	±5.1%	Normal	1	1	1	±5.1%	±5.1%		
Axial isotropy	±4.7%	Rectangular	√3	1	1	±2.7%	±2.7%		
Sensor Displacement	±16.5%	Rectangular	√3	1	0.145	±9.5%	±1.4%		
Boundary Effects	±2.4%	Rectangular	√3	1	1	±1.4%	±1.4%		
Linearity	±4.7%	Rectangular	√3	1	1	±2.7%	±2.7%		
Scaling to Peak Envelope Power	±2.0%	Rectangular	√3	1	1	±1.2%	±1.2%		
System Detection Limit	±1.0%	Rectangular	√3	1	1	±0.6%	±0.6%		
Readout Electronics	±0.3%	Rectangular	√3	1	1	±0.3%	±0.3%		
Response Time	±0.8%	Rectangular	√3	1	1	±0.5%	±0.5%		
Integration Time	±2.6%	Rectangular	√3	1	1	±1.5%	±1.5%		
RF Ambient Condition	±3.0%	Rectangular	√3	1	1	±1.7%	±1.7%		
RF Reflections	±12.0%	Rectangular	√3	1	1	±6.9%	±6.9%		
Probe Positioner	±1.2%	Rectangular	√3	1	0.67	±0.7%	±0.5%		
Probe Positioning	±4.7%	Rectangular	√3	1	0.67	±2.7%	±1.8%		
Extrap. And Interpolation	±1.0%	Rectangular	√3	1	1	±0.6%	±0.6%		
		TEST SAMPLE REI	ATED						
Device Positioning Vertical	±4.7%	Rectangular	√3	1	0.67	±2.7%	±1.8%		
Device Positioning Lateral	±1.0%	Rectangular	√3	1	1	±0.6%	±0.6%		
Device Holder and Phantom	±2.4%	Rectangular	√3	1	1	±1.4%	±1.4%		
Power Drift	±5.0%	Rectangular	√3	1	1	±2.9%	±2.9%		
	PHA	NTOM AND SETUP	RELATED						
Phantom Thickness	±2.4%	Rectangular	√3	1	0.67	±1.4%	±0.9%		
	COMBINED S	TD. UNCERTAINTY				±14.7%	±10.9%		
E	XPANDED STD. UN	NCERTAINTY ON P	OWER			±29.4%	±21.8%		
	EXPANDED STD. U	INCERTAINTY ON I	FIELD			±14.7%	±10.9%		

NOTE: Worst-case uncertainty budget for HAC free field assessment according to ANSI C63.19 [1]. The budget is valid for the frequency range 800MHz ~ 3GHz and represents a worst-case analysis. For specific tests and configurations, the uncertainty could be considerably smaller.



3.4. GENERAL DESCRIPTION OF THE HAC EVALUATION

The DASY4 post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the micro-volt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters: - Sensitivity

Norm_i, a_{i0}, a_{i1}, a_{i2}

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \bullet \frac{cf}{dcp_i}$$

 V_i = compensated signal of channel i (i = x, y, z)

 U_i = input signal of channel I (i = x, y, z)

Cf = crest factor of exciting field (DASY parameter)

 dcp_i = diode compression point (DASY parameter)



From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes:
$$E_i = \sqrt{\frac{V_1}{Norm_i \cdot ConvF}}$$

H-field probes:
$$H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$$

 V_i = compensated signal of channel I (i = x, y, z)

Norm_i = sensor sensitivity of channel i $\mu V/(V/m)$ 2 for E-field Probes (i = x, y, z)

ConvF = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

F = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

E = field strength in V/m

 E_{tot} = total field strength in V/m

NOTE: The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of < 5ms. In the current implementation, DASY4 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

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4. PERFORMANCE CATEGORIES

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

CATEGORY	TELEPHONE RF PARAMETERS < 960MHz				
NEAR FIELD	AWF	E-FIELD EMISSION CW (dBV/m)	E-FIELD EMISSION CW (V/m)	H-FIELD EMISSION CW (dBA/m)	H-FIELD EMISSION CW (A/m)
M1	0	56.0 to 61.0	631.0 to 1122.0	5.6 to 10.6	1.91 to 3.39
IVI I	-5	53.5 to 58.5	473.2 to 841.4	3.1 to 8.1	1.43 to 2.54
M2	0	51.0 to 56.0	354.8 to 631.0	0.6 to 5.6	1.07 to 1.91
IVIZ	-5	48.5 to 53.5	266.1 to 473.2	-1.9 to 3.1	0.80 to 1.43
M3	0	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07
IVIS	-5	43.5 to 48.5	149.6 to 266.1	-6.9 to -1.9	0.45 to 0.80
M4	0	< 46.0	< 199.5	< -4.4	< 0.60
141-4	-5	< 43.5	< 149.6	< -6.9	< 0.45

CATEGORY		TELEI	PHONE RF PARAM	ETERS > 960MHz	
NEAR FIELD	AWF	E-FIELD EMISSION CW (dBV/m)	E-FIELD EMISSION CW (V/m)	H-FIELD EMISSION CW (dBA/m)	H-FIELD EMISSION CW (A/m)
M1	0	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07
IVI I	-5	43.5 to 48.5	149.6 to 266.1	-6.9 to -1.9	0.45 to 0.80
M2	0	41.0 to 46.0	112.2 to 199.5	-9.4 to -4.4	0.34 to 0.60
IVIZ	-5	48.5 to 53.5	84.1 to 149.6	-11.9 to -6.9	H-FIELD EMISSION CW (A/m) 0.60 to 1.07 0.45 to 0.80 0.34 to 0.60 0.25 to 0.45 0.19 to 0.34
M3	0	36.0 to 41.0	63.1 to 112.2	-14.4 to -9.4	0.19 to 0.34
WIS	-5	33.5 to 38.5	47.3 to 84.1	-16.9 to -11.9	0.14 to 0.25
M4	0	< 36.0	< 63.1	< -14.4	< 0.19
1014	-5	< 33.5	< 47.3	< -16.9	< 0.14



ARTICULATION WEIGHING FACTOR (AWF)

The following AWF factors shall be used for the standard transmission protocols:

STANDARD	TECHNOLOGY	AWF (dB)
TIA/EIA/IS-2000	CDMA	0
TIA/EIA-136	TDMA (50Hz)	0
iDENTM	TDMA (22 and 11Hz)	0
J-STD-007	GSM (217)	-5
T1/T1P1/3GPP	UMTS (WCDMA)	0



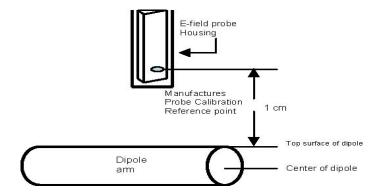
5. SYSTEM CHECK

The measured values (E-field and H-field) were compared with the values provided by the probe manufacturer and must within the allowed tolerance of **25%**.

5.1. VALIDATION STRUCTURE

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:

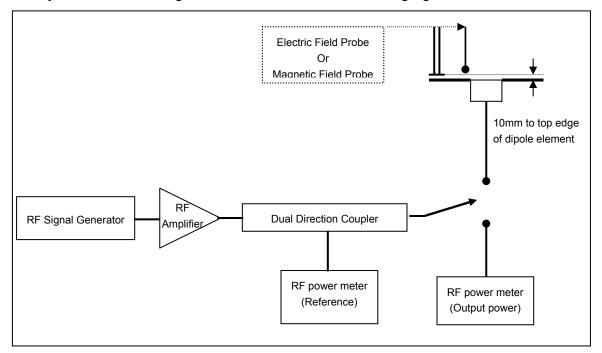




5.2. SYSTEM CHECK PROCEDURE

1. Before you start the system performance check, need only to tell the system with which components (probe type, validation dipole and HAC arch) are performing the system performance check; the system will take care of all parameters.

The system check configuration is shown in the following figure:



- 2. The dipole was energized with a 20dBm unmodulated continuous-wave signal.
- 3. The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded.



5.3. VALIDATION RESULTS

		S	YSTEM CHEC	K		
TEST FREQUENCY (MHz)	BEGIN TEST SG POWER (mW)	REQUIRED E-FILED (V/m)	MEASURED E-FILED (V/m)	DEVIATION (%)	SEPARATION DISTANCE (mm)	TESTED DATE
835	100.0	161.7	160.3	-0.87	10	Jun. 13, 2008
1880	100.0	137.4	129.7	-5.60	10	Jun. 13, 2008
TEST FREQUENCY (MHz)	BEGIN TEST SG POWER (mW)	REQUIRED H-FILED (V/m)	MEASURED H-FILED (V/m)	DEVIATION (%)	SEPARATION DISTANCE (mm)	TESTED DATE
835	100.0	0.457	0.456	-0.22	10	Jun. 13, 2008
1880	100.0	0.454	0.437	-3.74	10	Jun. 13, 2008
TESTED BY	Sam Onn					

NOTE: Please see Appendix for the system validation test data.



6. MODULATION FACTOR

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals are ensured to be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements.

This was done using the following procedure:

- 1. Fixing the probe in a set location relative to a field generating device, such as a reference dipole antenna, as illustrated in the system check procedure.
- 2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10dB above the probe system noise floor but within the systems operating range.
- 3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna.
- 4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
- 6. Record the reading of the probe measurement system of the unmodulated signal.
- 7. The RF signal generator producing an 80%AM signal and set to the wireless device operating frequency. Set the amplitude of the signal to equal that recorded from the wireless device.



- 8. Record the reading of the probe measurement system of the 80%AM signal.
- 9. The ratio, in linear units, of the probe reading in Step 3) or 8) to the reading in Step 6) is the E-field modulation factor.
- 10. Steps 1-9 were repeated at all frequency bands and for both E and H field probes.

NOTE: The ratio of the CW to modulated signal reading is the modulation factor. The modulation factors obtained were applied to readings taken of the actual wireless device, in order to obtain an accurate peak field reading using the formula:

Peak = 20 · log(Raw · ProbeModulationFactor)

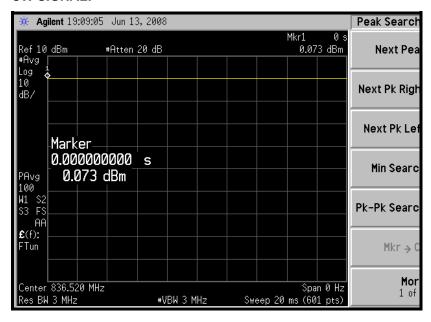
Report no.: HA970604L10 21 Report Format Version 1.0.0



6.1 MODULATION FACTOR TEST RESULTS

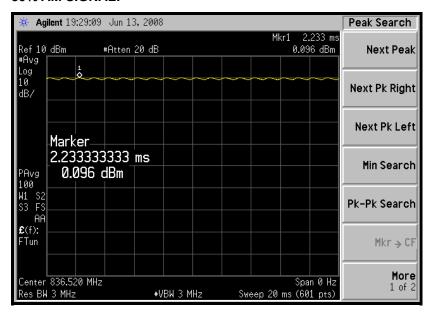
TEST FREQUENCY (MHz)	PROTOCOL	REFERENCE LEVEL	MEASURED E-FILED (V/m)	E-FILED MODULATION FACTOR	TESTED DATE
	CW		165.7	NA	
836.5	80% AM	Refer to the next three plots	150.5	1.10	Jun. 13, 2008
	CDMA		171.1	0.97	
TEST FREQUENCY (MHz)	PROTOCOL	REFERENCE LEVEL	MEASURED H-FILED (A/m)	H-FILED MODULATION FACTOR	TESTED DATE
	CW		0.468	NA	
836.5	80% AM	Refer to the next three plots	0.475	0.99	Jun. 13, 2008
	CDMA		0.498	0.94	
TESTED BY	Sam Onn				

CW SIGNAL:

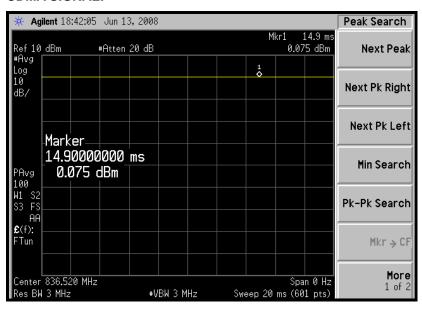




80% AM SIGNAL:



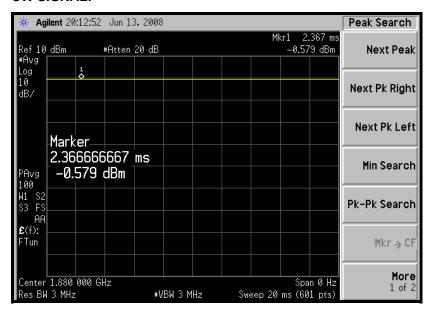
CDMA SIGNAL:





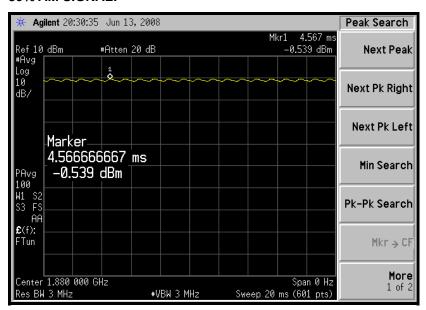
TEST FREQUENCY (MHz)	PROTOCOL	REFERENCE LEVEL	MEASURED E-FILED (V/m)	E-FILED MODULATION FACTOR	TESTED DATE
	CW		125.6	NA	
1880.0	80% AM	Refer to the next three plots	112.3	1.12	Jun. 13, 2008
	CDMA		128.4	0.98	
TEST FREQUENCY (MHz)	PROTOCOL	REFERENCE LEVEL	MEASURED H-FILED (A/m)	H-FILED MODULATION FACTOR	TESTED DATE
	CW		0.441	NA	
1880.0	80% AM	Refer to the next three plots	0.429	1.03	Jun. 13, 2008
	CDMA		0.473	0.93	
TESTED BY	Sam Onn				

CW SIGNAL:

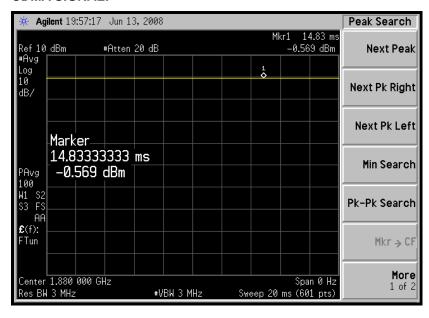




80% AM SIGNAL:



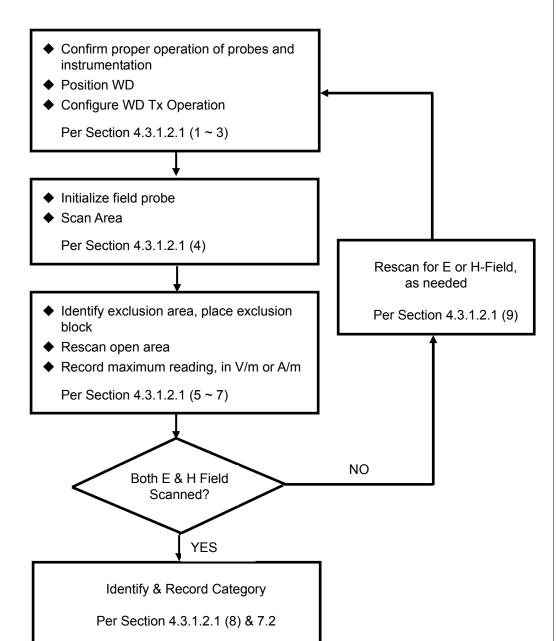
CDMA SIGNAL:





7. RF EMISSION TEST PROCEDURES

7.1. TEST INSTRUCTION





7.2. TEST PROCEDURES

The EUT (Pocket PC Phone) makes a phone call to the GSM base station. Establish the simulation communication configuration rather the actual communication. Then the EUT could continuous the transmission mode. Adjust the PCL of the base station could controlled the EUT to transmitted the maximum output power. The base station also could control the transmission channel.

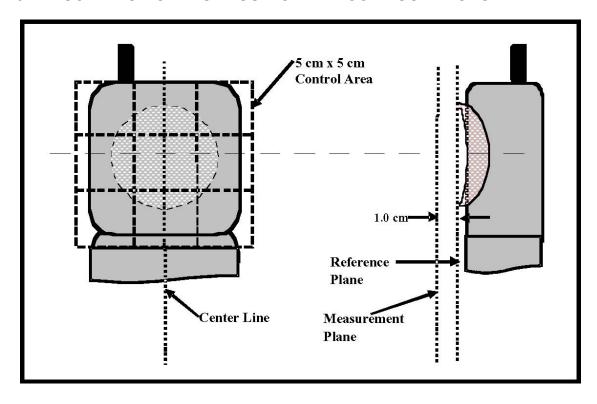
The recommended procedure for assessing the RF emission value consists of the following steps:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- 3. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 4. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC arch.
- 5. The measurement system measured the field strength at the reference location.
- 6. Measurements at 2mm increments in the 5 x 5cm region were performed and recorded. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 7. Steps 1-6 were done for both the E and H-Field measurements.

•



7.3. DESCRIPTION OF TEST POSITION AND CONFIGURATIONS





7.4. SUMMARY OF MEASURED HAC RESULTS

E-FIELD EMISSION

ENVIRON CONDITIO				mperature:2 dity:65%RH						
TESTED E	TESTED BY			Onn	DATE		Jun. 1	3, 2008		
FREQ. (MHz)	CHAN.	M	ODE	CONDUCTED POWER (dBm)	DRIFT (dB)	MEASURED PMF	_	LUDED ELLS	PEAK FIELD (V/m)	RATING
824.70 (Low)	1013	CDN	ЛА850	24.06	-0.077		6.	.8.9	50.7	M4
836.50 (Mid.)	384	CDN	ЛА850	24.28	-0.048	0.97	6.	.8.9	56.0	M4
848.30 (High)	777	CDN	ЛА850	24.41	-0.200	0.91	6.	.8.9	64.7	M4
848.30 (High)	777	_	MA850 ht off)	24.41	-0.002		6.	.8.9	62.5	M4

- 1. The LCD back-light "ON" & battery A are the worst case for measurement.
- 2. Please see the Appendix A for the measured data and test plots.
- 3. The variation of the EUT conducted power measured before and after HAC testing should not over 5%.



ENVIRON CONDITIO				mperature:2 dity:65%RH						
TESTED E	TESTED BY Sa			Onn	DATE		Jun. 1	3, 2008		
FREQ. (MHz)	CHAN.	M	ODE	CONDUCTED POWER (dBm)	DRIFT (dB)	MEASURED PMF			PEAK FIELD (V/m)	RATING
1851.25 (Low)	25	CDM	1A1900	24.12	-0.039		7	.8.9	60.6	M4
1880.00 (Mid.)	600	CDM	1A1900	24.23	-0.007	0.98	7	.8.9	65.0	М3
1908.75 (High)	1175	CDM	1A1900	24.45	-0.118	0.90	7	.8.9	67.6	М3
1908.75 (High)	1175	_	1A1900 jht off)	24.45	-0.002		7	.8.9	64.0	М3

- 1. The LCD back-light "ON" & battery A are the worst case for measurement.
- 2. Please see the Appendix A for the measured data and test plots.
- 3. The variation of the EUT conducted power measured before and after HAC testing should not over 5%.



H-FIELD EMISSION

ENVIRON CONDITIO			Air Temperature:22.8°C, Humidity:65%RH								
TESTED BY			Sam Onn			DATE		Jun. 1	3, 2008		
FREQ. (MHz)	CHAN.	M	ODE	CONDUCTED POWER (dBm)	DRIFT (dB)	MEASURED PMF	_	_	PEAK FIELD (A/m)	RATING	
824.70 (Low)	1013	CDI	MA850	24.06	-0.067		2	.3.6	0.159	M4	
836.50 (Mid.)	384	CDN	MA850	24.28	-0.086	0.94	2	.3.6	0.162	M4	
848.30 (High)	777	CDN	MA850	24.41	-0.084	0.94	2	.3.6	0.176	M4	
848.30 (High)	777	_	MA850 jht off)	24.41	-0.102		2	.3.6	0.171	M4	

- 1. The LCD back-light "ON" & battery A are the worst case for measurement.
- 2. Please see the Appendix A for the measured data and test plots.
- 3. The variation of the EUT conducted power measured before and after HAC testing should not over 5%.



_	Air Temperature : 22.8°C, CONDITION Humidity : 65%RH									
TESTED E	TESTED BY Sar			Onn	DATE		Jun. 1	3, 2008		
FREQ. (MHz)	CHAN.	M	ODE	CONDUCTED POWER (dBm)	DRIFT (dB)	MEASURED PMF		LUDED ELLS	PEAK FIELD (A/m)	RATING
1851.25 (Low)	25	CDM	1A1900	24.12	-0.211		2	.3.6	0.198	М3
1880.00 (Mid.)	600	CDM	1A1900	24.23	-0.124	0.93	2	.3.6	0.221	М3
1908.75 (High)	1175	CDM	1A1900	24.45	-0.156	0.33	2.3.6		0.225	М3
1908.75 (High)	1175		1A1900 jht off)	24.45	-0.137		2	.3.6	0.227	М3

- 1. The LCD back-light "ON" & battery A are the worst case for measurement.
- 2. Please see the Appendix A for the measured data and test plots.
- $3. \ The \ variation \ of \ the \ EUT \ conducted \ power \ measured \ before \ and \ after \ HAC \ testing \ should \ not \ over \ 5\%.$



8. INFORMATION ON THE TESTING LABORATORIES

We, ADT Corp., were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved by the following approval agencies according to ISO/IEC 17025.

USA FCC, UL, A2LA
GERMANY TUV Rheinland

JAPAN VCCI NORWAY NEMKO

CANADA INDUSTRY CANADA, CSA

R.O.C. TAF, BSMI, NCC

NETHERLANDS Telefication

SINGAPORE GOST-ASIA (MOU)

RUSSIA CERTIS (MOU)

Copies of accreditation certificates of our laboratories obtained from approval agencies can be downloaded from our web site:

<u>www.adt.com.tw/index.5/phtml</u>. If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab:Hsin Chu EMC/RF Lab:Tel: 886-2-26052180Tel: 886-3-5935343Fax: 886-2-26051924Fax: 886-3-5935342

Hwa Ya EMC/RF/Safety/Telecom Lab:

Tel: 886-3-3183232 Fax: 886-3-3185050

Web Site: www.adt.com.tw

The address and road map of all our labs can be found in our web site also.



Date/Time: 2008/6/13 15:05:26

Test Laboratory: Advance Data Technology

E-CDMA850-Ch1013

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 824.7 MHz

Communication System: CDMA; Frequency: 824.7 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 - SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Low Channel 1013/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = $\frac{50.7}{V/m}$

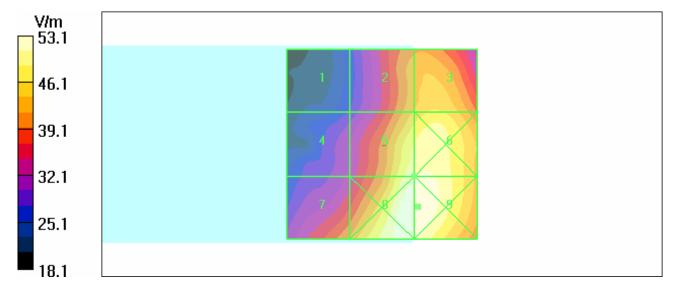
Probe Modulation Factor = 0.970

Reference Value = 41.8 V/m; Power Drift = -0.077 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
27.9	44.2	46.5
Grid 4	Grid 5	Grid 6
33.1	50.7	51.4
33.1	20.7	J1. T
	Grid 8	





Date/Time: 2008/6/13 15:10:51

Test Laboratory: Advance Data Technology

E-CDMA850-Ch384

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 836.5 MHz

Communication System: CDMA; Frequency: 836.5 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Mid Channel 384/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = $\frac{56.0}{\text{V/m}}$

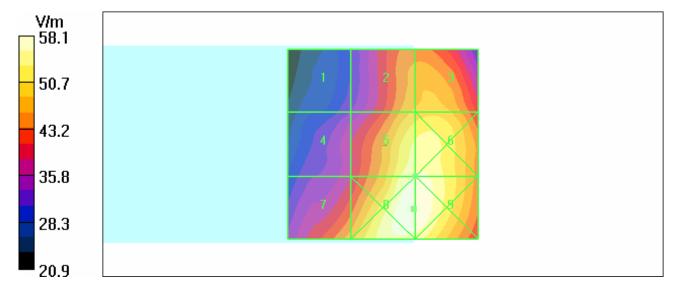
Probe Modulation Factor = 0.970

Reference Value = 47.6 V/m; Power Drift = -0.048 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
33.5	48.9	50.0
Grid 4	Grid 5	Grid 6
38.4	56.0	56.2
Grid 7	Grid 8	Grid 9
47.3	58.1	58.1





Date/Time: 2008/6/13 15:17:01

Test Laboratory: Advance Data Technology

E-CDMA850-Ch777

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 848.3 MHz

Communication System: CDMA; Frequency: 848.3 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 - SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference High Channel 777/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = $\frac{64.7}{\text{V/m}}$

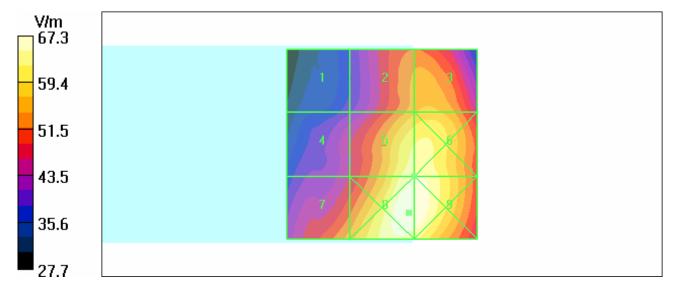
Probe Modulation Factor = 0.970

Reference Value = 56.8 V/m; Power Drift = -0.20 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
40.5	56.4	57.7
Grid 4	Grid 5	Grid 6
46.5	64.7	64.9
Grid 7	Grid 8	Grid 9





Date/Time: 2008/6/13 15:23:01

Test Laboratory: Advance Data Technology

E-CDMA850-Ch777 (Light Off)

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 848.3 MHz

Communication System: CDMA; Frequency: 848.3 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Mid Channel 777/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

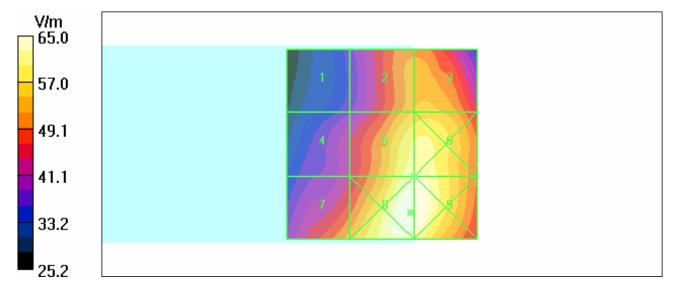
Maximum value of peak Total field = 62.5 V/m

Probe Modulation Factor = 0.970

Reference Value = 54.0 V/m; Power Drift = -0.002 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
38.4	54.9	55.7
Grid 4	Grid 5	Grid 6
44.1	62.5	62.8
Grid 7	Grid 8	Grid 9
53.2	65.0	64.9





Date/Time: 2008/6/13 15:35:50

Test Laboratory: Advance Data Technology

E-CDMA1900-Ch25

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1851.25 MHz

Communication System: CDMA; Frequency: 1851.25 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 - SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Low Channel 25/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

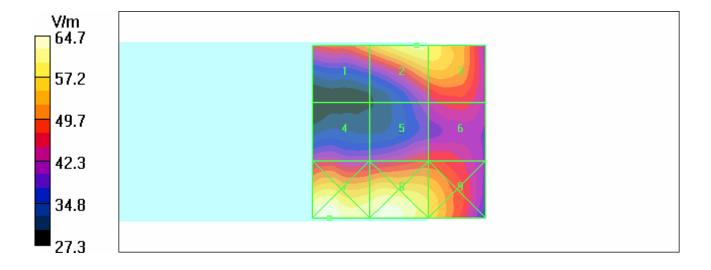
Maximum value of peak Total field = $\frac{60.6}{\text{V/m}}$

Probe Modulation Factor = 0.980

Reference Value = 35.1 V/m; Power Drift = -0.039 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
53.7	60.6	59.8
Grid 4	Grid 5	Grid 6
44.8	47.7	47.7
	47.7 Grid 8	





Date/Time: 2008/6/13 15:42:05

Test Laboratory: Advance Data Technology

E-CDMA1900-Ch600

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1880 MHz

Communication System: CDMA; Frequency: 1880 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 - SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference High Channel 1175/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

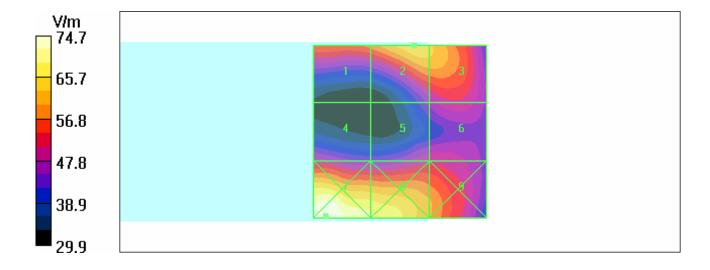
Maximum value of peak Total field = 65.0 V/m

Probe Modulation Factor = 0.980

Reference Value = 37.2 V/m; Power Drift = -0.007 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
58.2	65.0	63.4
Grid 4	Grid 5	Grid 6
49.5	50.1	50.2
	50.1 Grid 8	





Date/Time: 2008/6/13 15:57:23

Test Laboratory: Advance Data Technology

E-CDMA1900-Ch1175

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1908.75 MHz

Communication System: CDMA; Frequency: 1908.75 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 - SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Mid Channel 600/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

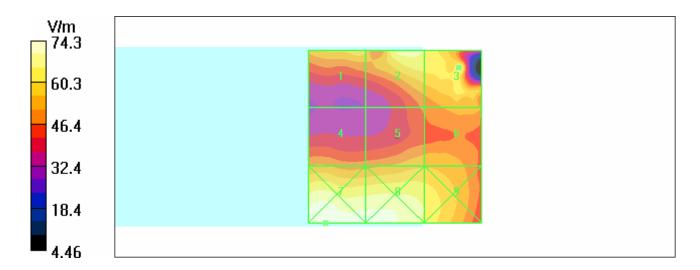
Maximum value of peak Total field = $\frac{67.6}{V/m}$

Probe Modulation Factor = 0.980

Reference Value = 40.1 V/m; Power Drift = -0.118 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
59.5	67.4	67.6
Grid 4	Grid 5	Grid 6
51.9	55.2	55.2
	55.2 Grid 8	





Date/Time: 2008/6/13 16:02:56

Test Laboratory: Advance Data Technology

E-CDMA1900-Ch1175 Light Off

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1908.75 MHz

Communication System: CDMA; Frequency: 1908.75 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³;

Phantom section: E Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above Device Reference Hghd Channel 1175/Hearing

Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

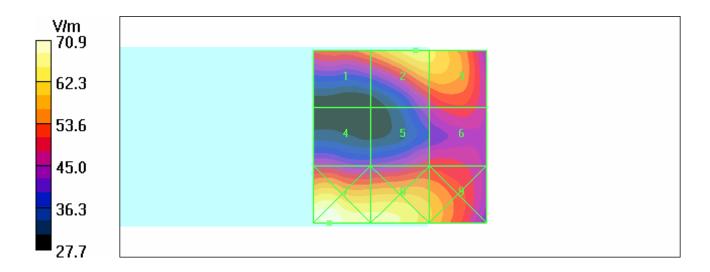
Maximum value of peak Total field = $\frac{64.0}{\text{V/m}}$

Probe Modulation Factor = 0.980

Reference Value = 33.1 V/m; Power Drift = -0.002 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
56.4	64.0	63.1
Grid 4	Grid 5	Grid 6
46.8	49.6	50.3
Grid 7	Grid 8	Grid 9
O114 /	0110 0	0114





Date/Time: 2008/6/13 10:51:14

Test Laboratory: Advance Data Technology

H-CDMA850-Ch1013

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 824.7 MHz

Communication System: CDMA; Frequency: 824.7 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference Low Channel 1013/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

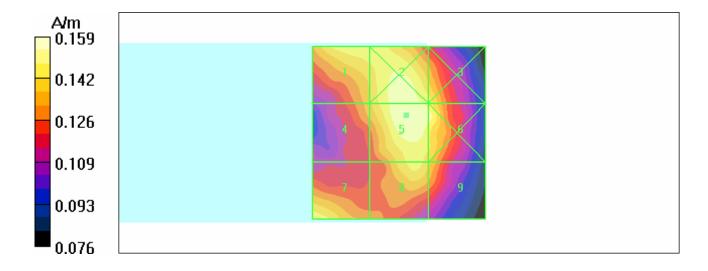
Maximum value of peak Total field = 0.159 A/m

Probe Modulation Factor = 0.940

Reference Value = 0.153 A/m; Power Drift = -0.067 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.152	0.157	0.151
Grid 4		
0.140	0.159	0.156
Grid 7		
0.153	0.150	0.143





Date/Time: 2008/6/13 11:00:26

Test Laboratory: Advance Data Technology

H-CDMA850-Ch384

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 836.5 MHz

Communication System: CDMA; Frequency: 836.5 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference Mid Channel 384/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

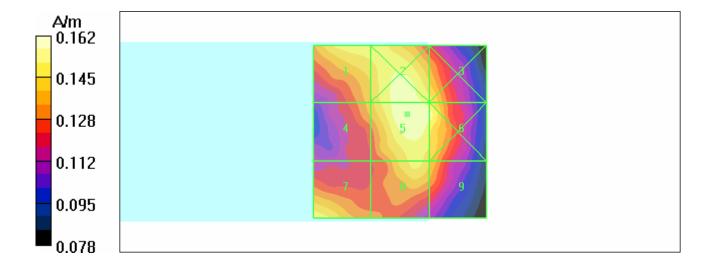
Maximum value of peak Total field = 0.162 A/m

Probe Modulation Factor = 0.940

Reference Value = 0.157 A/m; Power Drift = -0.086 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.154	0.160	0.153
Grid 4		
0.142	0.162	0.158
Grid 7	Grid 8	Grid 9
0.155	0.153	0.145





Date/Time: 2008/6/13 11:23:40

Test Laboratory: Advance Data Technology

H-CDMA850-Ch777

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 848.3 MHz

Communication System: CDMA; Frequency: 848.3 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section:

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference High Channel 777/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

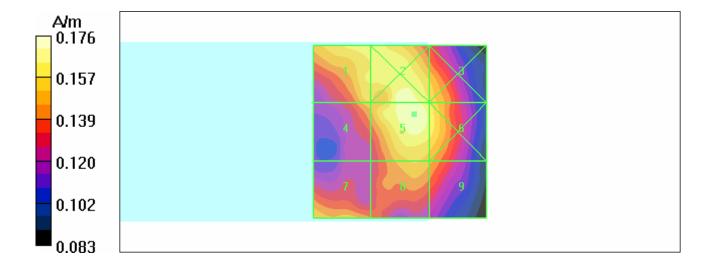
Maximum value of peak Total field = 0.176 A/m

Probe Modulation Factor = 0.940

Reference Value = 0.165 A/m; Power Drift = -0.084 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.166	0.174	0.163
Grid 4		
0.155	0.176	0.167
0.155 Grid 7 0.158	Grid 8	Grid 9





Date/Time: 2008/6/13 11:16:56

Test Laboratory: Advance Data Technology

H-CDMA850-Ch777 Light Off

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 848.3 MHz

Communication System: CDMA; Frequency: 848.3 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference High Channel 777/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

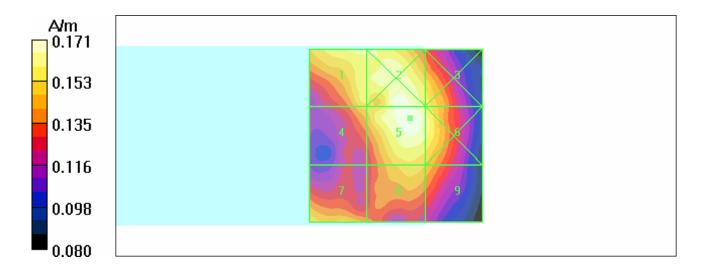
Maximum value of peak Total field = 0.171 A/m

Probe Modulation Factor = 0.940

Reference Value = 0.162 A/m; Power Drift = -0.102 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.161	0.168	0.158
Grid 4		
0.150	0.171	0.162
Grid 7	Grid 8	Grid 9
		0.147





Date/Time: 2008/6/13 11:45:17

Test Laboratory: Advance Data Technology

H-CDMA1900-Ch25

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1851.25 MHz

Communication System: CDMA; Frequency: 1851.25 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference Low Channel 25/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

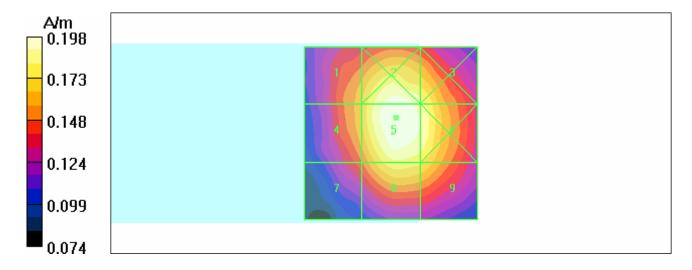
Maximum value of peak Total field = 0.198 A/m

Probe Modulation Factor = 0.930

Reference Value = 0.210 A/m; Power Drift = -0.211 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.165	0.194	0.185
Grid 4	Grid 5	Grid 6
0.166	0.198	0.190
Grid 7	Grid 8	Grid 9
0.148	0.180	0.174





Date/Time: 2008/6/13 11:52:21

Test Laboratory: Advance Data Technology

H-CDMA1900-Ch600

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1880 MHz

Communication System: CDMA; Frequency: 1880 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference Mid Channel 600/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

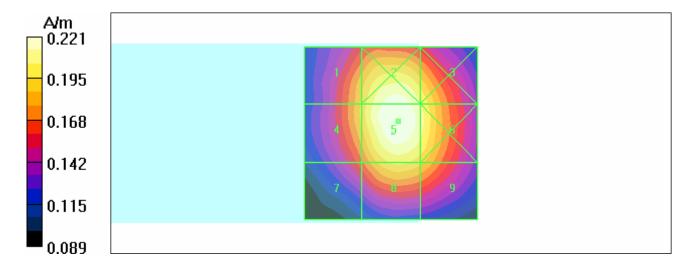
Maximum value of peak Total field = 0.221 A/m

Probe Modulation Factor = 0.930

Reference Value = 0.225 A/m; Power Drift = -0.124 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.188	0.217	0.204
Grid 4	Grid 5	Grid 6
0.189	0.221	0.208
	Grid 8	Grid 9





Date/Time: 2008/6/13 11:58:54

Test Laboratory: Advance Data Technology

H-CDMA1900-Ch1175

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1908.75 MHz

Communication System: CDMA; Frequency: 1908.75 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference High Channel 1175/Hearing

Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

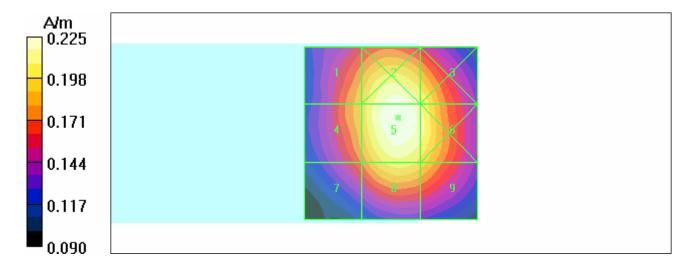
Maximum value of peak Total field = 0.225 A/m

Probe Modulation Factor = 0.930

Reference Value = 0.234 A/m; Power Drift = -0.156 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.190	0.221	0.208
Grid 4	Grid 5	Grid 6
0.191	0.225	0.212
Grid 7		
0.172	0.203	0.194





Date/Time: 2008/6/13 13:02:55

Test Laboratory: Advance Data Technology

H-CDMA1900-Ch1175 Light Off

DUT: Pocket PC Phone; Type: RAPH800; Test Frequency: 1908.75 MHz

Communication System: CDMA; Frequency: 1908.75 MHz; Duty Cycle: 1:1Modulation type: OQPSK

Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³;

Phantom section: H Device Section;

Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 - SN6124; ; Calibrated: 2007/1/23

- Sensor-Surface: (Fix Surface)

- Electronics: DAE3 Sn510; Calibrated: 2007/8/29

- Phantom: HAC Test Arch; Type: SD HAC P01 BA;

- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above Device Reference High Channel 1175/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

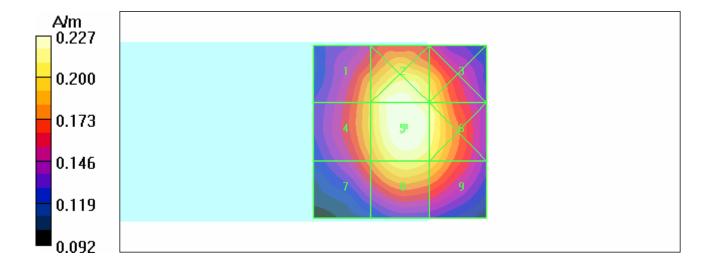
Maximum value of peak Total field = 0.227 A/m

Probe Modulation Factor = 0.930

Reference Value = 0.246 A/m; Power Drift = -0.137 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.194	0.223	0.207
Grid 4	Grid 5	Grid 6
0.195	0.227	0.216
	Grid 8	Grid 9





Date/Time: 2008/6/13 18:42:01

Test Laboratory: Advance Data Technology

E-836.5MHz (WD)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 836.5 MHz

Communication System: CDMA; Frequency: 836.5 MHz; Duty Cycle: 1:1; Modulation type: OQPSK

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

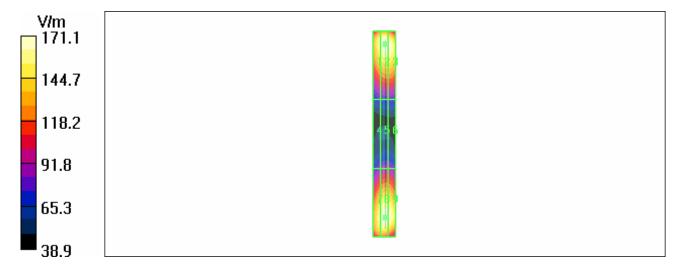
Maximum value of peak Total field = $\frac{171.1}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 123.5 V/m; Power Drift = -0.138 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
161.7	171.1	168.8
Grid 4	Grid 5	Grid 6
84.2	90.2	88.9
	90.2 Grid 8	





Date/Time: 2008/6/13 19:17:39

Test Laboratory: Advance Data Technology

E-836.5MHz (CW)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 836.5 MHz

Communication System: CW; Frequency: 836.5 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

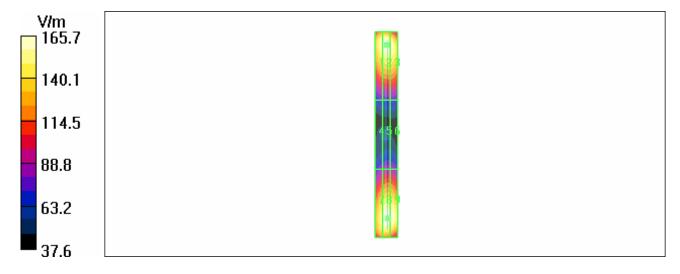
Maximum value of peak Total field = $\frac{165.7}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 121.3 V/m; Power Drift = -0.022 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
160.8	164.4	161.0
Grid 4	Grid 5	Grid 6
83.1	88.2	87.2
83.1 Grid 7		





Date/Time: 2008/6/13 19:33:37

Test Laboratory: Advance Data Technology

E-836.5MHz (AM 80%)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 836.5 MHz

Communication System: AM; Frequency: 836.5 MHz; Duty Cycle: 1:1; Modulation type: AM

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

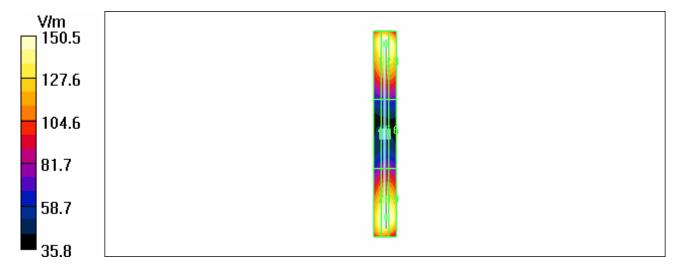
Maximum value of peak Total field = 150.5 V/m

Probe Modulation Factor = 1.00

Reference Value = 111.4 V/m; Power Drift = -0.038 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
146.6	149.7	148.6
Grid 4	Grid 5	Grid 6
78.6	82.5	81.7
	82.5 Grid 8	





Date/Time: 2008/6/13 18:54:58

Test Laboratory: Advance Data Technology

H-836.5MHz (WD)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 836.6 MHz

Communication System: CDMA; Frequency: 836.6 MHz; Duty Cycle: 1:1; Modulation type: OQPSK

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; ; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

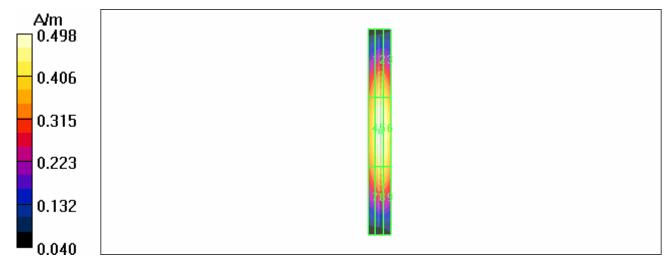
Maximum value of peak Total field = $\frac{0.498}{A}$ A/m

Probe Modulation Factor = 1.00

Reference Value = 0.522 A/m; Power Drift = -0.044 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.405	0.445	0.430
Grid 4	Grid 5	Grid 6
0.451	0.498	0.483
Grid 7		
0 396	0.440	0.429





Date/Time: 2008/6/13 19:08:40

Test Laboratory: Advance Data Technology

H-836.5MHz (CW)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 836.5 MHz

Communication System: CW; Frequency: 836.5 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

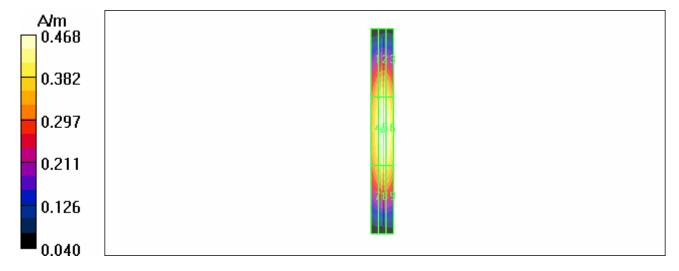
Maximum value of peak Total field = 0.468 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.497 A/m; Power Drift = -0.009 dB

Peak H-field in A/m

Grid 1		
0.383	0.420	0.408
Grid 4	Grid 5	Grid 6
0.427	0.468	0.458
Grid 7 0.375	Grid 8	Grid 9





Date/Time: 2008/6/13 19:43:29

Test Laboratory: Advance Data Technology

H-836.5MHz (AM 80%)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 835 MHz

Communication System: AM; Frequency: 835 MHz; Duty Cycle: 1:1; Modulation type: AM

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

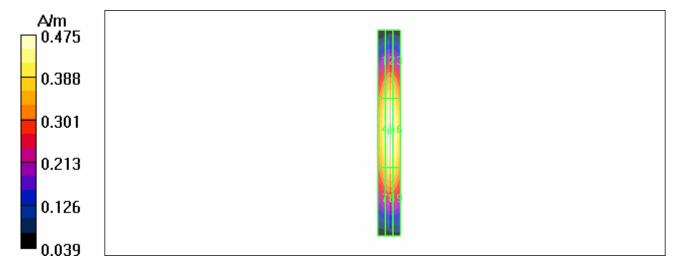
Maximum value of peak Total field = 0.475 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.502 A/m; Power Drift = -0.089 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.386	0.423	0.408
Grid 4	Grid 5	Grid 6
0.432	0.475	0.459
0.432 Grid 7 0.379	Grid 8	Grid 9





Date/Time: 2008/6/13 20:03:58

Test Laboratory: Advance Data Technology

E-1880MHz (WD)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CDMA; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: OQPSK Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

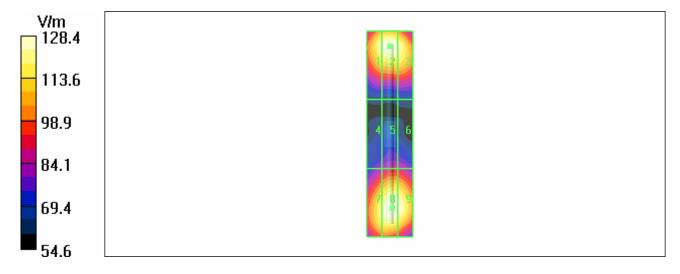
Maximum value of peak Total field = $\frac{128.4}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 129.4 V/m; Power Drift = -0.059 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
124.8	128.4	124.9
Grid 4	Grid 5	Grid 6
82.8	88.3	87.2
82.8 Grid 7		





Date/Time: 2008/6/13 20:12:31

Test Laboratory: Advance Data Technology

E-1880MHz (CW)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

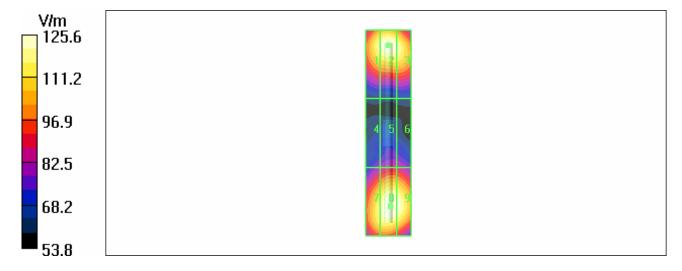
Maximum value of peak Total field = 125.6 V/m

Probe Modulation Factor = 1.00

Reference Value = 127.3 V/m; Power Drift = -0.103 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
121.2	125.4	121.9
Grid 4	Grid 5	Grid 6
81.3	86.6	85.8
81.3 Grid 7		





Date/Time: 2008/6/13 20:36:20

Test Laboratory: Advance Data Technology

E-1880MHz (AM 80%)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: AM; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: AM

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

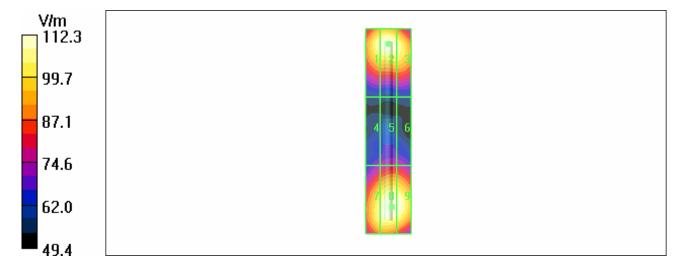
Maximum value of peak Total field = $\frac{112.3}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 115.8 V/m; Power Drift = -0.076 dB

Peak E-field in V/m

Grid 1 109.8		
Grid 4		
73.7	77.6	77.0





Date/Time: 2008/6/13 19:57:38

Test Laboratory: Advance Data Technology

H-1880MHz (WD)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CDMA; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: OQPSK

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

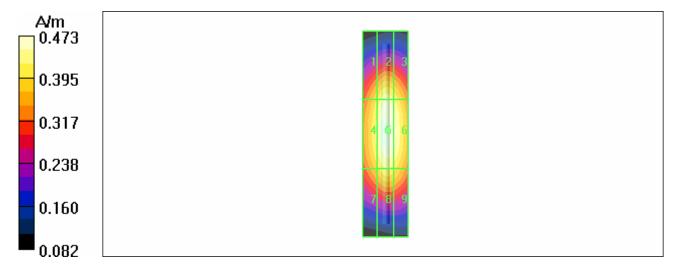
Maximum value of peak Total field = 0.473 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.499 A/m; Power Drift = -0.133 dB

Peak H-field in A/m

	Grid 2	
0.400	0.442	0.424
	Grid 5	
0.433	0.473	0.457
	Grid 8	
0.386	0.424	0.408





Date/Time: 2008/6/13 20:19:19

Test Laboratory: Advance Data Technology

H-1880MHz (CW)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

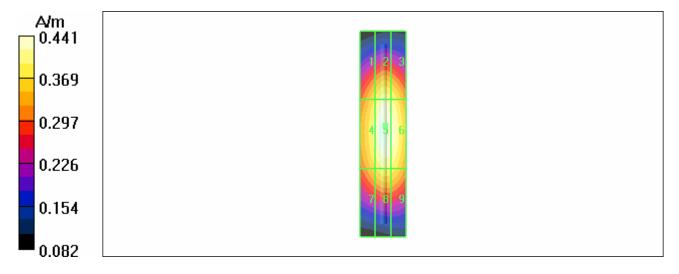
Maximum value of peak Total field = $\frac{0.441}{\text{A/m}}$

Probe Modulation Factor = 1.00

Reference Value = 0.464 A/m; Power Drift = -0.002 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.375	0.412	0.400
Grid 4	Grid 5	Grid 6
0.406	0.441	0.430
Grid 7		
0.365	0.395	0.388





Date/Time: 2008/6/13 20:30:23

Test Laboratory: Advance Data Technology

H-1880MHz (AM 80%)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: AM; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: AM

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; ; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

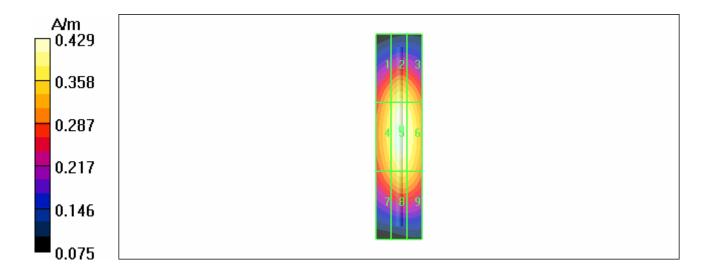
Maximum value of peak Total field = $\frac{0.429}{\text{A/m}}$

Probe Modulation Factor = 1.00

Reference Value = 0.451 A/m; Power Drift = -0.146 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.358	0.396	0.380
Grid 4	Grid 5	Grid 6
0.389	0.429	0.414
Grid 7	Grid 8	Grid 9
0.342	0.378	0.369





Date/Time: 2008/6/13 09:36:42

Test Laboratory: Advance Data Technology

E-835MHz (System Validation)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 835 MHz

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

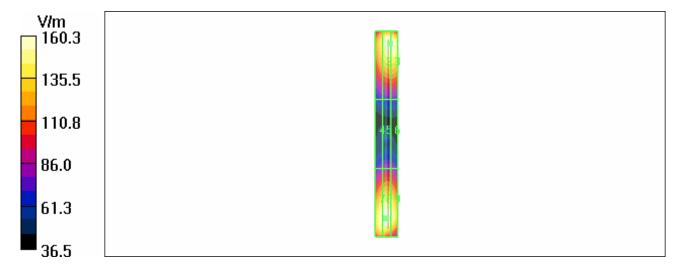
Maximum value of peak Total field = $\frac{160.3}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 117.7 V/m; Power Drift = -0.171 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
146.8	160.3	160.1
Grid 4	Grid 5	Grid 6
82.7	86.9	84.7
	Grid 8	Grid 9





Date/Time: 2008/6/13 09:45:24

Test Laboratory: Advance Data Technology

E-1880MHz (System Validation)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: ER3DV6 SN2293; ConvF(1, 1, 1); Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

E Scan - ER probe center 10mm above CD1880 Dipole 2/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

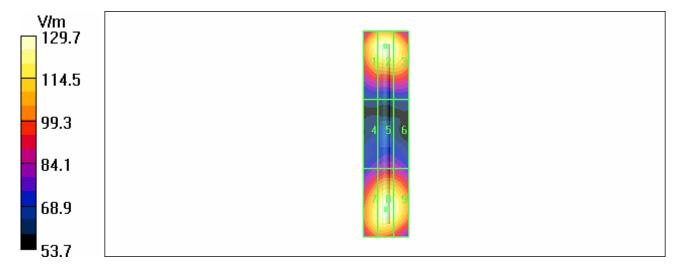
Maximum value of peak Total field = $\frac{129.7}{V/m}$

Probe Modulation Factor = 1.00

Reference Value = 129.6 V/m; Power Drift = -0.138 dB

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
125.7	129.7	125.9
Grid 4	Grid 5	Grid 6
82.0	86.9	85.6
	86.9 Grid 8	





Date/Time: 2008/6/13 10:03:44

Test Laboratory: Advance Data Technology

H-835MHz (System Validation)

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041; Test Frequency: 835 MHz

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; ; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD835 Dipole/Hearing Aid Compatibility Test

(41x361x1): Measurement grid: dx=5mm, dy=5mm

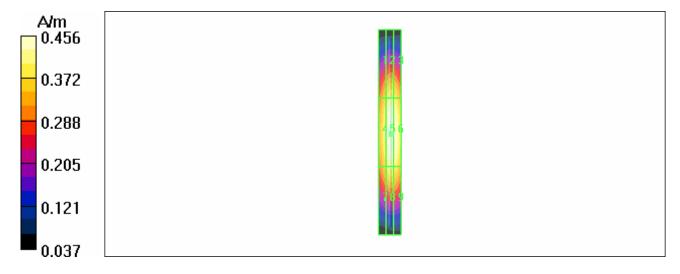
Maximum value of peak Total field = 0.456 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.475 A/m; Power Drift = -0.215 dB

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.366	0.406	0.395
Grid 4	Grid 5	Grid 6
0.414	0.456	0.448
Grid 7		
0.367	0.408	0.401





Date/Time: 2008/6/13 10:09:03

Test Laboratory: Advance Data Technology

H-1880MHz (System Validation)

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032; Test Frequency: 1880 MHz

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1; Modulation type: CW

Medium: Air; Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section Measurement Standard: DASY4 (High Precision Assessment);

DASY4 Configuration:

- Probe: H3DV6 SN6124; ; Calibrated: 2007/1/23
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn510; Calibrated: 2007/8/29
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

H Scan - ER probe center 10mm above CD1880 Dipole/Hearing Aid Compatibility Test

(41x181x1): Measurement grid: dx=5mm, dy=5mm

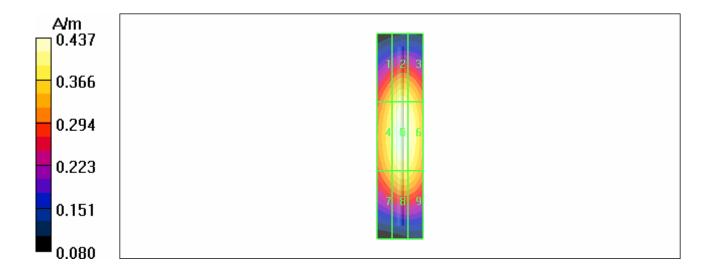
Maximum value of peak Total field = 0.437 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.455 A/m; Power Drift = -0.104 dB

Peak H-field in A/m

Grid 1		
0.369	0.407	0.397
Grid 4	Grid 5	Grid 6
0.401	0.437	0.427
Grid 7	Grid 8	Grid 9
0 361	0 394	0.387





APPENDIX B: SYSTEM CERTIFICATE & CALIBRATION

B1: E-FIELD PROBE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
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Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

Cllent

ADT (Auden)

Centificate No: ER3-2293 Uan07

CHAOLINE DINOPPALEINA

Object ER3DV6 - SN:2293

Calibration procedure(s) QA CAL=02.v4

Calibration procedure for E-field probes optimized for close near field

evaluations in air.

Calibration date: January 23, 2007

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
GB41293874	5-Apr-06 (METAS, No. 251-00557)	Apr-07
MY41495277	5-Apr-06 (METAS, No. 251-00557)	Apr-07
MY41498087	5-Apr-06 (METAS, No. 251-00557)	Apr-07
SN: S5054 (3c)	10-Aug-06 (METAS, No. 217-00592)	Aug-07
SN: S5086 (20b)	4-Apr-06 (METAS, No. 251-00558)	Apr-07
SN: S5129 (30b)	10-Aug-06 (METAS, No. 217-00593)	Aug-07
SN: 2328	2-Oct-06 (SPEAG, No. ER3-2328_Oct06)	Oct-07
SN: 654	21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Jun-07
] ID #	Check Date (in house)	Scheduled Check
US3642U01700	4-Aug-99 (SPEAG, in house check Nov-05)	In house check: Nov-07
US37390585	18-Oct-01 (SPEAG, in house check Oct-06)	In house check: Oct-07
Name	Function	Signature
Katja Pokovic	Technical Manager:	27 WD
		16Cus 164
Niels Kuster	Quality Manager	\ / / \
		$V \cdot V \otimes S = 0$
	· · · · · · · · · · · · · · · · · · ·	
	GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 2328 SN: 654 ID # US3642U01700 US37390585 Name Kātja Pokovic	GB41293874 5-Apr-06 (METAS, No. 251-00557) MY41495277 5-Apr-06 (METAS, No. 251-00557) MY41498087 5-Apr-06 (METAS, No. 251-00557) SN: S5054 (3c) 10-Aug-06 (METAS, No. 217-00592) SN: S5086 (20b) 4-Apr-06 (METAS, No. 251-00558) SN: S5129 (30b) 10-Aug-06 (METAS, No. 217-00593) SN: 2328 2-Oct-06 (SPEAG, No. ER3-2328_Oct06) SN: 654 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) ID # Check Date (in house) US3642U01700 4-Aug-99 (SPEAG, in house check Nov-05) US37390585 18-Oct-01 (SPEAG, in house check Oct-06) Name Function Kātja Pokovic: Technical Manager

Issued: January 23, 2007

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





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Servizio svizzero di taratura
S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z

sensitivity in free space

DCP Polarization φ diode compression point φ rotation around probe axis

Polarization 8

9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-1996, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 for XY sensors and θ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

ER3DV6 SN:2293 January 23, 2007

Probe ER3DV6

SN:2293

Manufactured:

October 1, 2002

Last calibrated:

September 22, 2005

Recalibrated:

January 23, 2007

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

ER3DV6 SN:2293 January 23, 2007

DASY - Parameters of Probe: ER3DV6 SN:2293

Sensitivity in Free Space $[\mu V/(V/m)^2]$

Diode Compression^A

NormX 1.27 ± 10.1 % (k=2) NormY 1.06 ± 10.1 % (k=2) DCP X **95** mV DCP Y **95** mV

NormZ **1.42** ± 10.1 % (k=2)

DCP Z 96 mV

Frequency Correction

Χ

0.0

Υ

0.0

Ζ

0.0

Sensor Offset

(Probe Tip to Sensor Center)

Х

2.5 mm

Υ

2.5 mm

Z

2.5 mm

Connector Angle

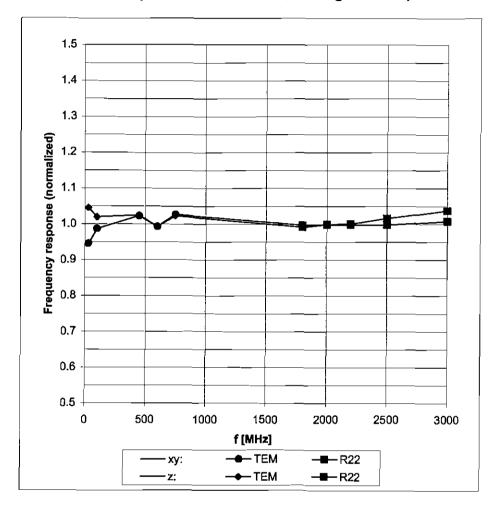
-12 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

A numerical linearization parameter: uncertainty not required

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide R22)

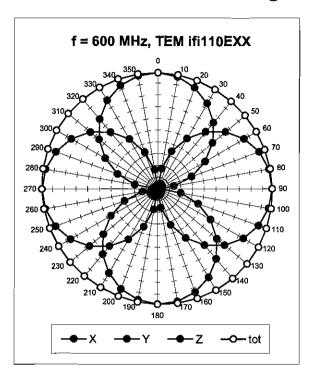


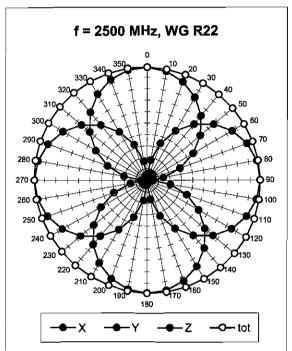
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

January 23, 2007

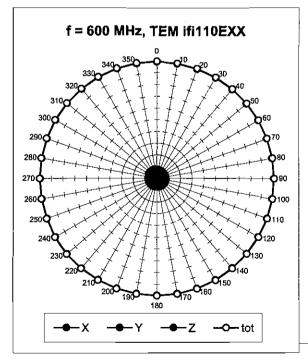
ER3DV6 SN:2293

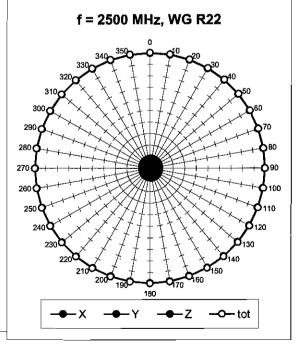
Receiving Pattern (ϕ), ϑ = 0°





Receiving Pattern (ϕ), ϑ = 90°

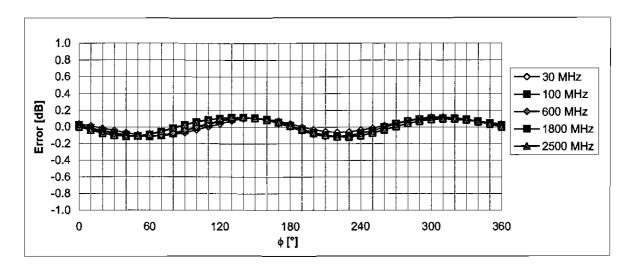




January 23, 2007

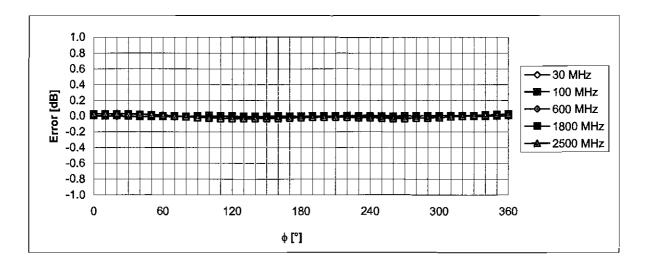
ER3DV6 SN:2293

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

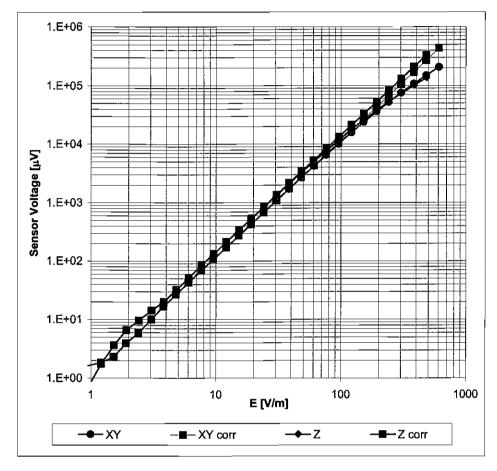


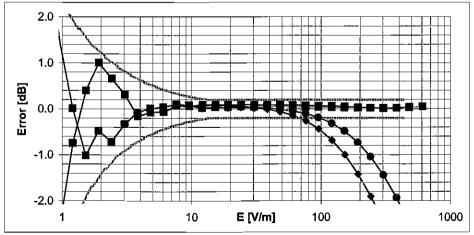
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

January 23, 2007

Dynamic Range f(E-field)

(Waveguide R22, f = 1800 MHz)

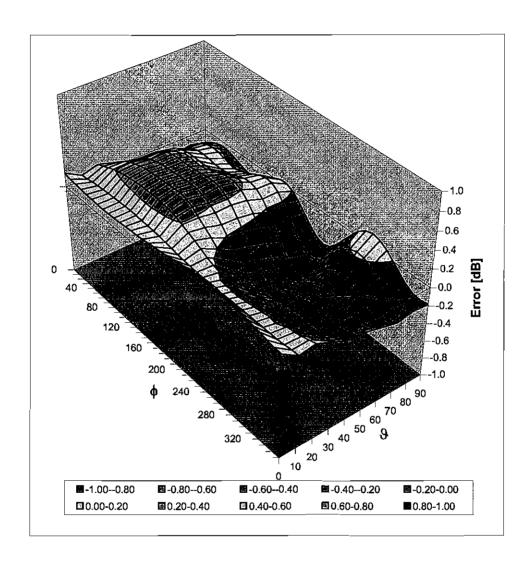




Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: ER3-2293_Jan07

Deviation from Isotropy in Air Error (ϕ, ϑ) , f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)



B2: H-FIELD PROBE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 108

Client

ADT (Auden)

Certificate No: H3-6124 Jan 07

Constitution of the second	and the particular contraction of the contraction o	THE CONTROL OF THE PROPERTY OF	makes a principal program of the pro
ABERATIONS			
Dbject	H3DV6 - SN.61	24	
Calibration procedure(s)	QA CAL-03.v4-		
	Galibration proc evaluations in a	edure for H-field probes optimized for ir	r close near field
Calibration date:	January 23, 200	17	
Condition of the calibrated item	In Tolerance	· · · · · · · · · · · · · · · · · · ·	
his calibration certificate docum	nents the traceability to na	itional standards, which realize the physical units of	f measurements (SI).
	=	probability are given on the following pages and are	
All calibrations have been condu	cted in the closed laborat	ory facility: environment temperature (22 ± 3)°C and	d humidity < 70%.
All calibrations have been condu			d humidity < 70%.
alibration Equipment used (M&			d humidity < 70%. Scheduled Calibration
Calibration Equipment used (M& Primary Standards	TE critical for calibration)		
ralibration Equipment used (M& rimary Standards ower meter E4419B	TE critical for calibration)	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
ralibration Equipment used (M& rimary Standards lower meter E4419B lower sensor E4412A	TE critical for calibration) ID # GB41293874	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07 Apr-07
calibration Equipment used (M& rimary Standards lower meter E4419B lower sensor E4412A lower sensor E4412A	ID # GB41293874 MY41495277	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ID # GB41293874 MY41495277 MY41498087	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Scheduled Calibration Apr-07 Apr-07 Apr-07
	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07
Calibration Equipment used (M&Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07
Calibration Equipment used (M&Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07
Calibration Equipment used (M& Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. H3-6182_Oct06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Oct-07
Calibration Equipment used (M&Crimary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 RAE4	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. H3-6182_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Apr-07 Aug-07 Oct-07 Jun-07
Calibration Equipment used (M&Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference Probe H3DV6 DAE4 Recondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. H3-6182_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check
Calibration Equipment used (M&Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Recondary Standards RF generator HP 8648C Network Analyzer HP 8753E	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654 ID # US3642U01700 US37390585 Name	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 217-00593) 2-Oct-06 (SPEAG, No. H3-6182_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Oct-06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check In house check: Nov-07
Calibration Equipment used (M&Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Recondary Standards RF generator HP 8648C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654 ID # US3642U01700 US37390585	Cal Date (Calibrated by, Certificate No.) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 10-Aug-06 (METAS, No. 217-00592) 4-Apr-06 (METAS, No. 251-00558) 10-Aug-06 (METAS, No. 251-00593) 2-Oct-06 (SPEAG, No. H3-6182_Oct06) 21-Jun-06 (SPEAG, No. DAE4-654_Jun06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Oct-06)	Scheduled Calibration Apr-07 Apr-07 Apr-07 Aug-07 Aug-07 Oct-07 Jun-07 Scheduled Check In house check: Nov-07 In house check: Oct-07
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issued: January 23, 2007

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Glossary:

NORMx,y,z

sensitivity in free space

DCP

diode compression point φ rotation around probe axis

Polarization φ Polarization 9

9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Connector Angle

information used in DASY system to align probe sensor X to the robot

coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-1996, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- X,Y,Z_a0a1a2: Assessed for E-field polarization θ = 90 for XY sensors and θ = 0 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X a0a1a2 (no uncertainty required).

January 23, 2007

Probe H3DV6

SN:6124

Manufactured:

June 8, 2002

Last calibrated:

September 22, 2005

Recalibrated:

January 23, 2007

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

H3DV6 SN:6124

H3DV6 SN:6124 January 23, 2007

DASY - Parameters of Probe: H3DV6 SN:6124

Sensitivity in Free Space [A/m / $\sqrt{(\mu V)}$]

a0 a1 a2 X 2.679E-03 -9.856E-5 5.307E-5 ± 5.1 % (k=2) Y 2.790E-03 -2.467E-4 3.051E-5 ± 5.1 % (k=2) Z 3.037E-03 -1.907E-4 1.047E-5 ± 5.1 % (k=2)

Diode Compression¹

DCP X 86 mV DCP Y 86 mV DCP Z 88 mV

Sensor Offset (Probe Tip to Sensor Center)

X 3.0 mm Y 3.0 mm Z 3.0 mm

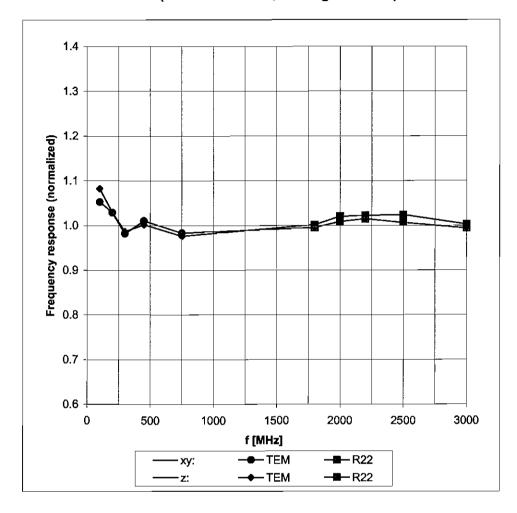
Connector Angle -25 °

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

¹ numerical linearization parameter: uncertainty not required

Frequency Response of H-Field

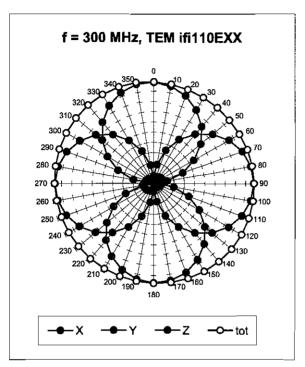
(TEM-Cell:ifi110, Waveguide R22)

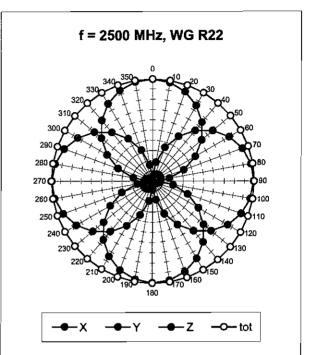


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

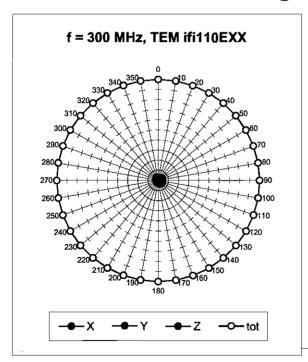
H3DV6 SN:6124 January 23, 2007

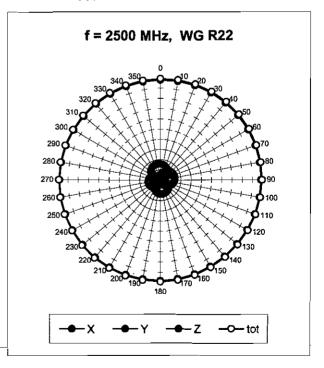
Receiving Pattern (ϕ), ϑ = 90°





Receiving Pattern (ϕ), ϑ = 0°



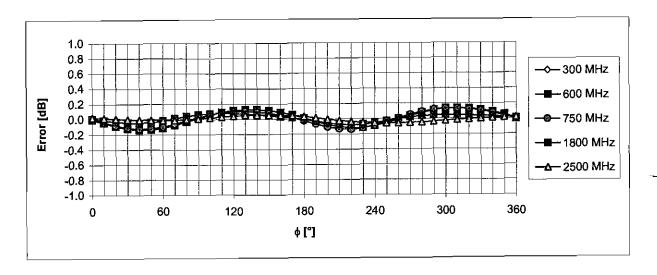


Certificate No: H3-6124_Jan07

January 23, 2007

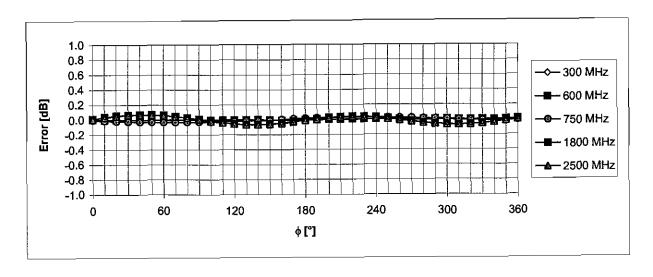
H3DV6 SN:6124

Receiving Pattern (ϕ), ϑ = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), ϑ = 0°

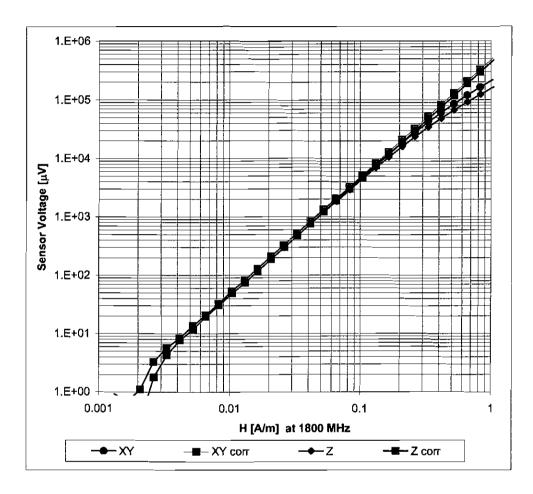


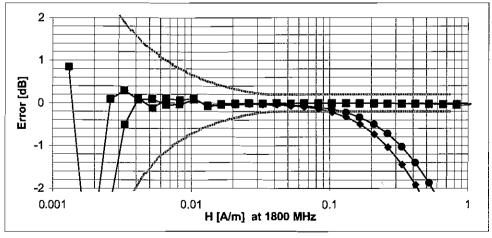
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

H3DV6 SN:6124 January 23, 2007

Dynamic Range f(H-field)

(Waveguide R22, f = 1800 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Certificate No: H3-6124_Jan07



B3: DAE

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C

Client

ADT (Auden)

Certificate No: DAE3-510 Aug 07

CALIBRATION CERTIFICATE DAE3 - SD 000 D03 AA - SN: 510 Object QA CAL-06 v12 Calibration procedure(s) Calibration procedure for the data acquisition electronics (DAE) August 29, 2007 Calibration date: In Tolerance Condition of the calibrated item This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards Cal Date (Calibrated by, Certificate No.) Scheduled Calibration SN: 6295803 13-Oct-06 (Elcal AG, No: 5492) Oct-07 Fluke Process Calibrator Type 702 Oct-07 SN: 0810278 03-Oct-06 (Elcal AG, No: 5478) Keithley Multimeter Type 2001 1D# Scheduled Check Secondary Standards Check Date (in house) In house check Jun-08 Calibrator Box V1.1 SE UMS 006 AB 1004 25-Jun-07 (SPEAG, in house check) **Function** Signature Name Dominique Steffen Calibrated by: Technician Approved by: Fin Bomholt R&D Director Issued: August 29, 2007 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Glossary

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
- AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1L

1LSB =

6.1μV ,

full range = -100...+300 mV

Low Range:

1LSB =

61nV ,

full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	х	Y	Z
High Range	404.150 ± 0.1% (k=2)	404.218 ± 0.1% (k=2)	404.585 ± 0.1% (k=2)
Low Range	3.98817 ± 0.7% (k=2)	3.97339 ± 0.7% (k=2)	3.96897 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	42°±1°	
Connector Angle to be deed in Brief Cyclem		

Certificate No: DAE3-510_Aug07

Appendix

1. DC Voltage Linearity

High Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	200000	200000.7	0.00
Channel X	+ Input	20000	20006.63	0.03
Channel X	- Input	20000	-19999.14	0.00
Channel Y	+ Input	200000	199999.5	0.00
Channel Y	+ Input	20000	20005.23	0.03
Channel Y	- Input	20000	-20002.04	0.01
Channel Z	+ Input	200000	199999.6	0.00
Channel Z	+ Input	20000	20006.53	0.03
Channel Z	- Input	20000	-20001.38	0.01

Low Range		Input (μV)	Reading (μV)	Error (%)
Channel X	+ Input	2000	2000	0.00
Channel X	+ Input	200	199.97	-0.01
Channel X	- Input	200	-199.90	-0.05
Channel Y	+ Input	2000	2000.1	0.00
Channel Y	+ Input	200	199.64	-0.18
Channel Y	- Input	200	-200.58	0.29
Channel Z	+ Input	2000	2000	0.00
Channel Z	+ Input	200	199.20	-0.40
Channel Z	- Input	200	-200.81	0.41

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	17.82	16.82
	- 200	-16.18	-16.83
Channel Y	200	14.68	14.20
	- 200	-15.70	-16.05
Channel Z	200	-8.25	-8.73
	- 200	8.01	8.08

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.75	1.74
Channel Y	200	2.34	-	2.77
Channel Z	200	-1.43	0.25	-

Certificate No: DAE3-510_Aug07 Page 4 of 5 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15893	16120
Channel Y	16114	16051
Channel Z	16081	16196

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MQ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (μV)
Channel X	-0.67	-1.71	-0.06	0.26
Channel Y	-1.04	-3.37	0.35	0.34
Channel Z	-1.26	-3.29	0.15	0.35

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2001	198.5
Channel Y	0.2001	199.2
Channel Z	0.2000	200.3

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values					
Supply (+ Vcc)	+0.0	+6	+14		
Supply (- Vcc)	-0.01	-8	-9		

Certificate No: DAE3-510_Aug07 Page 5 of 5



B4: VALIDATION DIPOLE

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Client

ADT (Auden)

Certificate No: CD835V3-1041_May08

CALIBRATION CERTIFICATE

CD835V3 - SN: 1041 Object

QA CAL-20.v4 Calibration procedure(s)

Calibration procedure for dipoles in air

May 14, 2008 Calibration date:

In Tolerance Condition of the calibrated item

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}$ C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-07 (No. 217-00736)	Oct-08
Power sensor HP 8481A	US37292783	04-Oct-07 (No. 217-00736)	Oct-08
Probe ER3DV6	SN: 2336	31-Dec-07 (No. ER3-2336_Dec07)	Dec-08
Probe H3DV6	SN: 6065	31-Dec-07 (No. H3-6065Dec07)	Dec-08
DAE4	SN: 781	2-Oct-07 (No. DAE4-781_Oct07)	Oct-08
	I		
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Secondary Standards Power meter EPM-4419B	ID # GB42420191	Check Date (in house) 11-May-05 (in house check Oct -07)	Scheduled Check In house check: Nov-08
		,	
Power meter EPM-4419B	GB42420191	11-May-05 (in house check Oct -07)	In house check: Nov-08
Power meter EPM-4419B Power sensor HP 8482A	GB42420191 US37295597	11-May-05 (in house check Oct -07) 11-May-05 (in house check Oct -07)	In house check: Nov-08 In house check: Nov-08
Power meter EPM-4419B Power sensor HP 8482A Power sensor HP 8482H	GB42420191 US37295597 3318A09450	11-May-05 (in house check Oct -07) 11-May-05 (in house check Oct -07) 08-Jan-02 (in house check Oct -07)	In house check: Nov-08 In house check: Nov-08 In house check: Nov-08
Power meter EPM-4419B Power sensor HP 8482A Power sensor HP 8482H Network Analyzer HP 8753E	GB42420191 US37295597 3318A09450 US37390585	11-May-05 (in house check Oct -07) 11-May-05 (in house check Oct -07) 08-Jan-02 (in house check Oct -07) 18-Oct-01 (in house check Oct-07)	In house check: Nov-08 In house check: Nov-08 In house check: Nov-08 In house check: Nov-09

Function Name Calibrated by: Mike Meili Laboratory Technician

Approved by: Fin Bomholt **Technical Director**

Issued: May 19, 2008

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References

[1] ANSI-C63.19-2006

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole
 connector is set with a calibrated power meter connected and monitored with an auxiliary power meter
 connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to
 the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan.
 The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated
 as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at
 the feed point.

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

)// = B=/
DASY Version	DASY4	V4.7 B71
DASY PP Version	SEMCAD	V1.8 B184
Phantom	HAC Test Arch	SD HAC P01 BA, #1070
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.456 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end-	100 mW forward power	164.3 V/m
Maximum measured above low end	100 mW forward power	160.9 V/m
Averaged maximum above arm	100 mW forward power	162.6 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	15.6 dB	(41.0 - j12.3) Ohm
835 MHz	27.7 dB	(50.0 + j4.1) Ohm
900 MHz	17.6 dB	(54.7 – j13.2) Ohm
950 MHz	18.2 dB	(48.6 + j12.2) Ohm
960 MHz	13.8 dB	(58.0 + j21.1) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

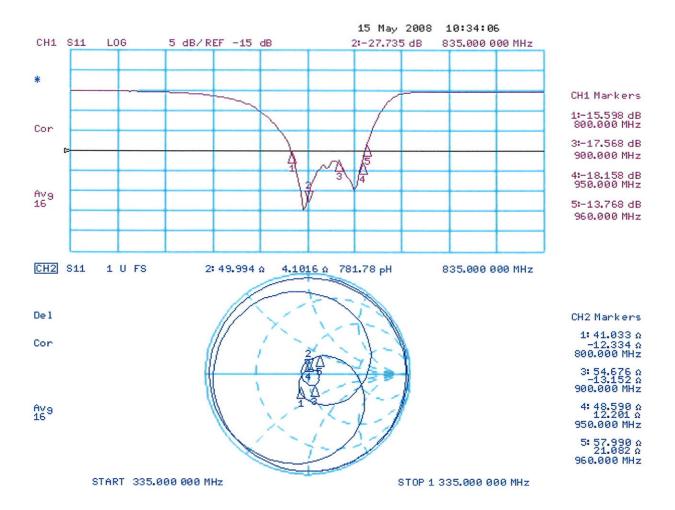
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD835V3-1041_May08 Page 3 of 6

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



3.3.2 DASY4 H-field result

Date/Time: 13.05.2008 12:52:58

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m³

Phantom section: RF Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

Probe: H3DV6 - SN6065; Calibrated: 31.12.2007

• Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 02.10.2007

• Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

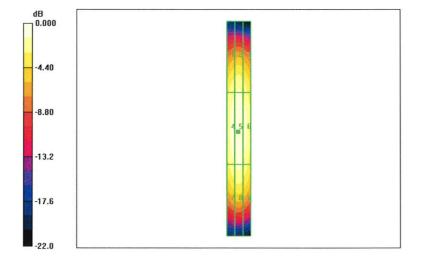
Maximum value of peak Total field = 0.456 A/m

Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm Reference Value = 0.485 A/m; Power Drift = -0.025 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.381	0.399	0.374
M4	M4	M4
Grid 4	Grid 5	Grid 6
0.434	0.456	0.427
M4	M4	M4
Grid 7	Grid 8	Grid 9
0.385	0.404	0.378
M4	M4	M4



0 dB = 0.456 A/m

Certificate No: CD835V3-1041_May08

Date/Time: 14.05.2008 11:32:24

Test Laboratory: SPEAG Lab 2

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1041

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2007

• Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 02.10.2007

Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1070

Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

E Scan - Sensor Center 10mm above CD835 Dipole/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

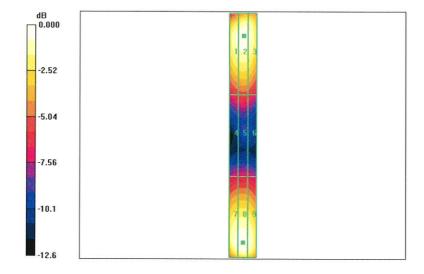
Maximum value of peak Total field = 164.3 V/m

Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 105.9 V/m; Power Drift = -0.005 dB **Hearing Aid Near-Field Category: M4 (AWF 0 dB)**

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
155.7	160.9	157.3
M4	M4	M4
Grid 4	Grid 5	Grid 6
85.3	88.0	85.7
M4	M4	M4
Grid 7	Grid 8	Grid 9
157.9	164.3	159.0
M4	M4	M4



0 dB = 164.3 V/m

Certificate No: CD835V3-1041_May08 Page 6 of 6

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





C

S

Accreditation No.: SCS 108

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Certificate No: CD1880V3-1032 Jul06

Client ADT (Auden)

CALIBRATION CERTIFICATE

Object CD1880V3 - SN: 1032

Calibration procedure(s) QA CAL-20.v4

Calibration procedure for dipoles in air

Calibration date: July 18, 2006

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-05 (METAS, No. 251-00516)	Oct-06
Power sensor HP 8481A	US37292783	04-Oct-05 (METAS, No. 251-00516)	Oct-06
Reference 20 dB Attenuator	SN: 5086 (20g)	11-Aug-05 (METAS, No 251-00498)	Aug-06
Reference 10 dB Attenuator	SN: 5047.2 (10r)	11-Aug-05 (METAS, No 251-00498)	Aug-06
DAE4	SN: 660	1-Mar-06 (SPEAG, No. DAE4-660_Mar06)	Calibration, Mar-07
Probe ER3DV6	SN: 2336	20-Dec-05 (SPEAG, No. ER3-2336_Dec05)	Calibration, Dec-06
Probe H3DV6	SN: 6065	20-Dec-05 (SPEAG, No. H3-6065-Dec05)	Calibration, Dec-06
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power meter EPM-4419B	GB43310788	12-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-06
Power sensor HP 8481A	MY41093312	10-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-07
Power sensor HP 8481A	MY41093315	10-Aug-03 (SPEAG, in house check Oct-05)	In house check: Oct-06
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-05)	In house check: Nov-06
RF generator R&S SMT06	SN: 100005	26-Jul-04 (SPEAG, in house check Nov-05)	In house check: Nov-07
		S	
	Name	Function	Signature

Calibrated by: Mike Meili Laboratory Technician

Approved by: Fin Bomholt Technical Director F

Issued: July 20, 2006

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD1880V3-1032_Jul06

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
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S wiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

References

[1] ANSI-PC63.19-2001 (Draft 3.x, 2005)
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate.
 All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E- field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field
 scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field
 value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the
 dipole surface at the feed point.

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7B44
DASY PP Version	SEMCAD	V1.8 B171
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz ± 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured	100 mW forward power	0.454 A/m

Uncertainty for H-field measurement: 8.2% (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW forward power	137.4 V/m
Maximum measured above low end	100 mW forward power	132.5 V/m
Averaged maximum above arm	100 mW forward power	135.0 V/m

Uncertainty for E-field measurement: 12.8% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	21.6 dB	(50.3 + j8.4) Ohm
1880 MHz	21.2 dB	(51.9 + j8.7) Ohm
1900 MHz	21.8 dB	(54.0 + j7.5) Ohm
1950 MHz	26.8 dB	(54.8 + j0.3) Ohm
2000 MHz	22.4 dB	(43.3 + j2.3) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

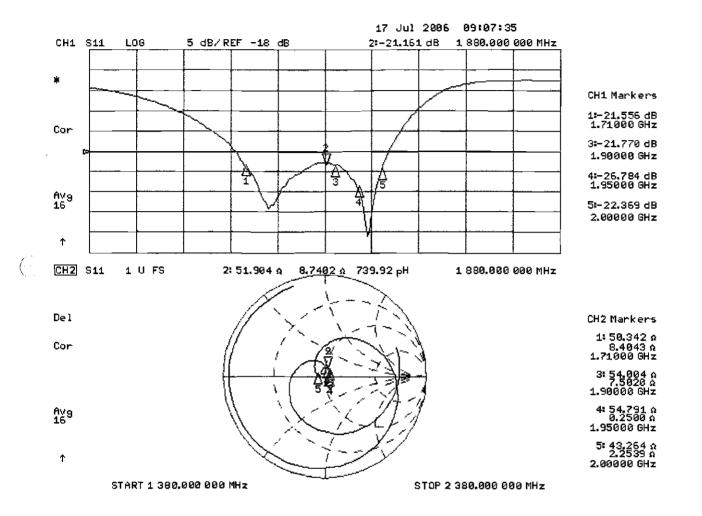
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



3.3.2 DASY4 H-field result

Date/Time: 7/18/2006 10:03:46 AM

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section

DASY4 Configuration:

• Probe: H3DV6 - SN6065; Calibrated: 12/20/2005

• Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn660; Calibrated: 3/1/2006

Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002

Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

H Scan - Sensor Center 10mm above CD1880V3 Dipole/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

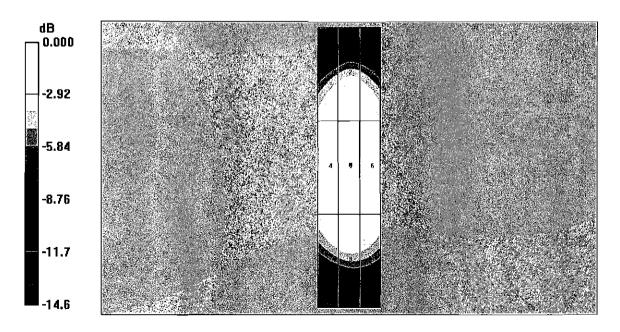
Maximum value of peak Total field = 0.454 A/m

Probe Modulation Factor = 1.00

Reference Value = 0.479 A/m; Power Drift = -0.002 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.397	0.422	0.404
Grid 4	Grid 5	Grid 6
0.429	0.454	0.438
0.429 Grid 7	0.454 Grid 8	0.438 Grid 9



0 dB = 0.454 A/m

Certificate No: CD1880V3-1032_Jul06

3.3.3 DASY4 E-Field result

Date/Time: 7/18/2006 11:39:04 AM

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1032

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: E Dipole Section

DASY4 Configuration:

• Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 12/20/2005

Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn660; Calibrated: 3/1/2006

Phantom: HAC Test Arch 4.6; Type: SD HAC P01 BA; Serial: 1002

Measurement SW: DASY4, V4.7 Build 44; Postprocessing SW: SEMCAD, V1.8 Build 171

E Scan - Sensor Center 10mm above CD1880V3 Dipole/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

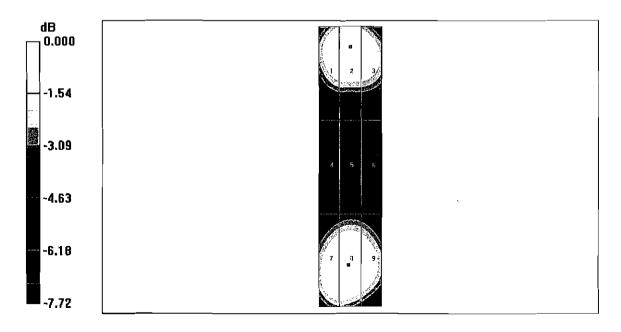
Maximum value of peak Total field = 137.4 V/m

Probe Modulation Factor = 1.00

Reference Value = 132.3 V/m; Power Drift = -0.002 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
132.8	137.4	131.7
Grid 4	Grid 5	Grid 6
87.6	90.7	88.7
87.6 Grid 7	90.7 Grid 8	88.7 Grid 9



0 dB = 137.4 V/m

Certificate No: CD1880V3-1032_Jul06